

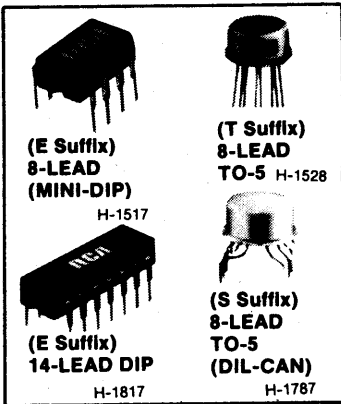
BiMOS Operational Amplifiers

With MOS/FET Input, Composite Bipolar/MOS Output

Single Amplifier: CA080, CA081
 Dual Amplifier: CA082, CA083
 Quad Amplifier: CA084

Features:

- Very low input bias and offset currents
- Input impedance typically $1.5 \times 10^{12} \Omega$
- Low input offset voltage
- Wide common-mode input voltage range
- Low power consumption
- Fast slew rate
- Unity-gain bandwidth = 5 MHz (typ.)
- Wide output voltage swing



The RCA-CA080, CA081, CA082, CA083, and CA084 BiMOS operational amplifiers combine the advantages of MOS and bipolar transistors on the same monolithic chip. The gate-protected MOS/FET (PMOS) input transistors provide high input impedance and a wide common-mode input voltage range. The bipolar and MOS output transistors allow a wide output voltage swing and provide a high output current capability.

- Low distortion
- Continuous short circuit protection
- Direct replacement for industry type TL080 series in most applications

Applications:

- Inverters
- High-Q notch filters
- IC preamplifiers
- Unity Gain Absolute Value Amplifiers
- Sample and hold amplifiers
- Active filters

Package Selection Chart

Type No.	Package Type & Suffix			
	8L TO-5	DIL-CAN	Mini-DIP	14L DIP
CA080	T	S	E	
CA080A	T	S	E	
CA080B			E	
CA080C	T	S		
CA081	T	S	E	
CA081A	T	S	E	
CA081B			E	
CA081C	T	S		
CA082	T	S	E	
CA082A	T	S	E	
CA082B			E	
CA082C	T	S		
CA083				E
CA083A				E
CA083B				E
CA084				E
CA084A				E
CA084B				E

The CA080 is externally phase-compensated, and the CA081, CA082, CA083, and CA084 are internally phase-compensated. All types except the CA082 have provisions for external offset nulling.

The CA080, CA081, CA082, CA083, and CA084 are available in chip form (H Suffix).

Operating Temperature Ranges:

-55 to +125° C

0 to +70° C

- CA080T, CA080S
- CA080AT, CA080AS
- CA081T, CA081S
- CA081AT, CA081AS
- CA082T, CA082S
- CA082AT, CA082AS

- CA080CT, CA080CS
- CA080BE
- CA081CT, CA081CS
- CA081BE
- CA082CT, CA082CS
- CA082BE
- CA083BE, CA083AE
- CA083BE
- CA084, CA084AE
- CA084BE

CA080 ...

CA080, CA081, CA082, CA083, CA084 Series

MAXIMUM RATINGS, Absolute Maximum Values:

DC SUPPLY VOLTAGE V_{\pm}	± 18 V
DIFFERENTIAL INPUT VOLTAGE	± 16 V
INPUT VOLTAGE RANGE	± 15 V
INPUT CURRENT	1 mA
OUTPUT SHORT-CIRCUIT DURATION	UNLIMITED*
POWER DISSIPATION, P_d :	
At $T_a = 25^{\circ}\text{C}$:	
E Suffix	625 mW
T Suffix	680 mW
Derating Factors:	
Mini-DIP	Derate linearly at 6.67 mW/ $^{\circ}\text{C}$ above 56°C
14-Lead DIP	Derate linearly at 6.67 mW/ $^{\circ}\text{C}$ above 56°C
TO-5	Derate linearly at 6.67 mW/ $^{\circ}\text{C}$ above 56°C
AMBIENT TEMPERATURE RANGE:	
CT, CS, E, Suffixes	0 to $+70^{\circ}\text{C}$
T, S, Suffixes	-55 to $+125^{\circ}\text{C}$
STORAGE TEMPERATURE RANGE, ALL TYPES	-65 to $+150^{\circ}\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ (1.59 ± 0.79 mm) from case for 10 seconds max.	$+265^{\circ}\text{C}$

* The output may be shorted to ground or either supply if the maximum temperature and dissipation ratings are observed.

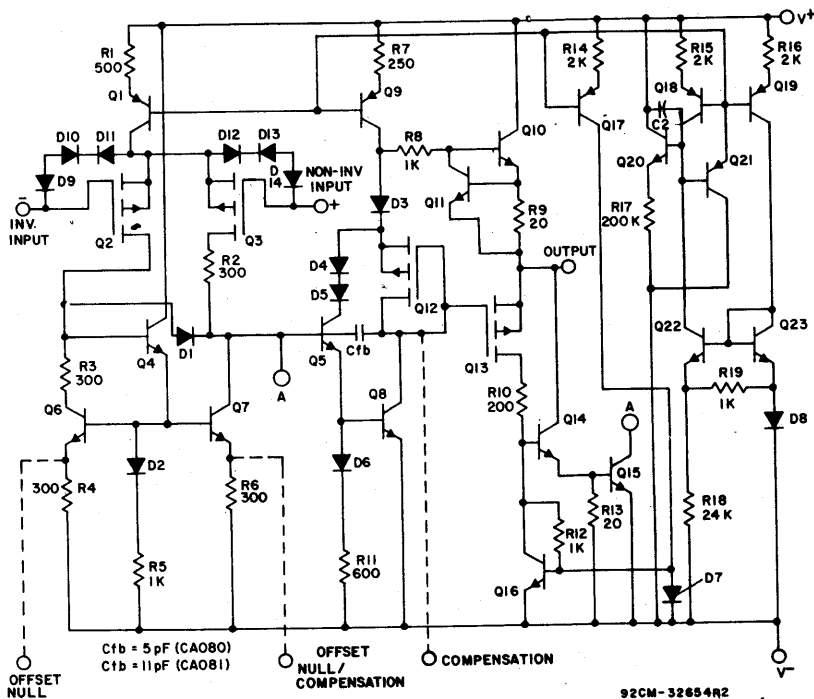


Fig. 1 - Schematic diagram of the CA080, CA081, CA082, CA083, and CA084.

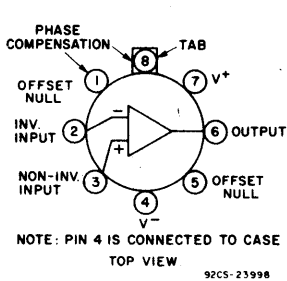
Texas Instruments-to-RCA Package Suffix Cross Reference Chart

Texas Instruments

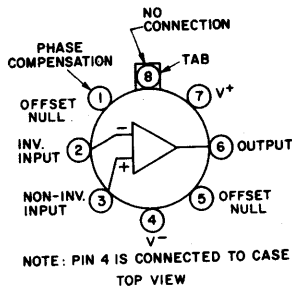
Suffix	Description
ACJG	Ceramic DIL
ACL	TO-5
ACN	Plastic DIL
ACP	Plastic DIL
CJG	Ceramic DIL
CL	TO-5
CN	Plastic DIL
CP	Plastic DIL
IJG	Ceramic DIL
IL	TO-5
IP	Plastic DIL
MJG	Ceramic DIL
ML	TO-5
AML	TO-5
BCP	Plastic DIL

RCA

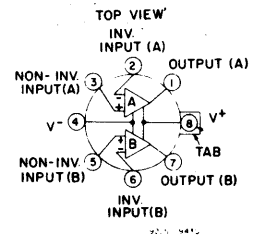
Suffix	Description
AS	DILCAN TO-5
AT	TO-5
AE	Plastic DIL
AE	Plastic DIL
CS	DILCAN TO-5
CT	TO-5
E	Plastic DIL
E	Plastic DIL
S	DILCAN TO-5
T	TO-5
E	DILCAN TO-5
S	DILCAN TO-5
T	TO-5
AT	TO-5
BE	Plastic DIL



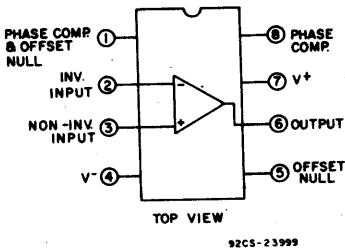
CA080
T, S Suffixes



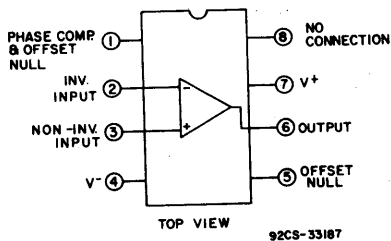
CA081
T, S Suffixes



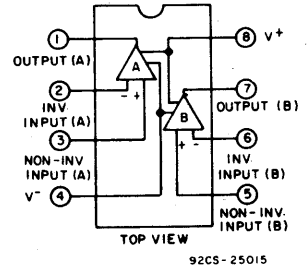
CA082
T, S Suffixes



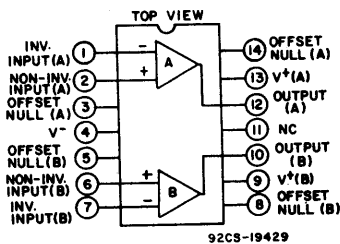
CA080
E Suffix



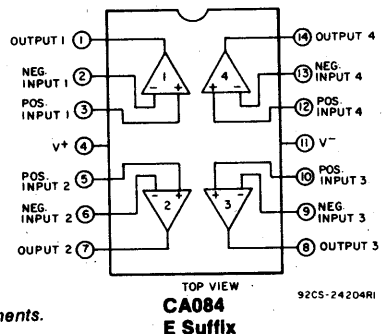
CA081
E Suffix



CA082
E Suffix



CA083
E Suffix



CA084
E Suffix

Fig. 2 - Terminal assignments.

CA080, CA081, CA082, CA083, CA084 Series

TYPICAL OPERATING CHARACTERISTICS at $V_{\pm} = 15\text{ V}$, $T_A = 25^{\circ}\text{C}$

CHARACTERISTIC	TEST CONDITIONS	VALUE	UNITS
Slew Rate at Unity Gain, SR	$V_I = 10\text{ V}$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, $A_{VD} = 1$	13	$\text{V}/\mu\text{s}$
Rise Time, t_r	$V_I = 10\text{ V}$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, $A_{VD} = 1$	0.1	μs
Overshoot Factor	$C_L = 100\text{ pF}$, $A_{VD} = 1$	10	%
Equivalent Input Noise Voltage, e_n	$R_S = 100\ \Omega$, $f = 1\text{ kHz}$	40	$\text{nV}/\sqrt{\text{Hz}}$

ELECTRICAL CHARACTERISTICS at $T_A = 25^{\circ}\text{C}$ and $T_A = -55$ to $+125^{\circ}\text{C}$ for types supplied in TO-5 style packages (T, S Suffixes). $V_{\pm} = \pm 15\text{ V}$

This does not include CA080C, CA081C, or CA082C. These types are supplied in TO-5 packages, but they are specified over the range of 0 to 70°C , and their limits are the same as those for the CA080, CA081, CA082, and CA083 in plastic packages over the range 0 to 70°C .

CHARACTERISTIC	TEST CONDITIONS		LIMITS						UNITS
			CA080T, S CA081T, S CA082T, S			CA080AT, S CA081AT, S CA082AT, S			
			Min.	Typ.	Max.	Min.	Typ.	Max.	
Input Offset Voltage, V_{IO}	$R_S = 50\ \Omega$	X	—	3	6	—	2	3	mV
		X	—	—	9	—	—	5	
Temperature Coefficient of Input Offset Voltage, αV_{IO}	$R_S = 50\ \Omega$	X	—	10	—	—	10	—	$\mu\text{V}/^{\circ}\text{C}$
Input Offset Current, I_{IO}		X	—	5	20	—	5	20	pA
		X	—	—	4	—	—	2	nA
Input Current		X	—	15	40	—	15	40	pA
		X	—	—	10	—	—	5	nA
Common-Mode Input Voltage Range, V_{ICR}		X	± 12	—	—	± 12	—	—	V
Maximum Output Voltage Swing, V_{OP-P}	$R_L = 10\text{ k}\Omega$	X	24	27	—	24	27	—	V
	$R_L \geq 10\text{ k}\Omega$	X	24	—	—	24	—	—	
	$R_L \geq 2\text{ k}\Omega$	X	20	24	—	20	24	—	
Large-Signal Differential Voltage Gain, A_{VD}	$R_L \geq 2\text{ k}\Omega$, $V_O = \pm 10\text{ V}$	X	50	200	—	50	200	—	V/mV
		X	25	—	—	25	—	—	
Unity-Gain Bandwidth		X	—	5	—	—	5	—	MHz
Input Resistance, R_I		X	—	1.5	—	—	1.5	—	$\text{T}\Omega$
Common-Mode Rejection Ratio, CMRR	$R_S \leq 10\text{ k}\Omega$	X	80	86	—	80	86	—	dB
Power Supply Rejection Ratio, PSRR ($\Delta V_{\pm} / \pm \Delta V_{IO}$)	$R_S \leq 10\text{ k}\Omega$	X	80	86	—	80	86	—	dB
Supply Current, I_{+} (per amp., CA082, CA083)	No load, No Signal	X	—	1.4	2.8	—	1.4	2.8	mA
Channel Separation, V_{O1}/V_{O2} (between amps., CA082, CA083)	$A_{VD} = 100$	X	—	120	—	—	120	—	dB

ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$, $T_A = 0$ to $+70^\circ\text{C}$
for types supplied in plastic dual-in-line packages (E Suffix). $V^+ = \pm 15\text{ V}$

CHARACTERISTIC	TEST CONDITIONS		LIMITS						UNITS
			CA080BE CA081BE CA082BE CA083BE CA084BE			CA080AE CA081AE CA082AE CA083AE CA084AE			
			Min.	Typ.	Max.	Min.	Typ.	Max.	
Input Offset Voltage, V_{IO}	$R_S = 50\Omega$	X	—	2	3	—	3	6	mV
		X	—	—	5	—	—	7.5	
Temperature Coefficient of Input Offset Voltage, αV_{IO}	$R_S = 50\Omega$	X	—	10	—	—	10	—	$\mu\text{V}/^\circ\text{C}$
Input Offset Current, I_{IO}		X	—	5	10	—	5	20	pA
		X	—	—	0.4	—	—	0.6	nA
Input Current		X	—	15	30	—	15	40	pA
		X	—	—	0.7	—	—	1	nA
Common-Mode Input Voltage Range, V_{ICR}		X	± 12	—	—	± 12	—	—	V
Maximum Output Voltage Swing, V_{OP-P}	$R_L = 10\text{ k}\Omega$	X	24	27	—	24	27	—	V
	$R_L \geq 10\text{ k}\Omega$	X	24	—	—	24	—	—	
	$R_L \geq 2\text{ k}\Omega$	X	20	24	—	20	24	—	
Large-Signal Differential Voltage Gain, A_{VD}	$R_L \geq 2\text{ k}\Omega$, $V_O = \pm 10\text{V}$	X	50	200	—	50	200	—	V/mV
		X	—	—	—	—	—	—	
Unity-Gain Bandwidth		X	—	5	—	—	5	—	MHz
Input Resistance, R_i		X	—	1.5	—	—	1.5	—	$\text{T}\Omega$
Common-Mode Rejection Ratio, CMRR	$R_S < 10\text{ k}\Omega$	X	80	86	—	80	86	—	dB
Power Supply Rejection Ratio, PSRR ($\Delta V^+ / \pm \Delta V_{IO}$)	$R_S < 10\text{ k}\Omega$	X	80	86	—	80	86	—	dB
Supply Current, I^+ (per amp., CA082, CA083, CA084)	No load, No Signal	X	—	1.4	2.8	—	1.4	2.8	mA
Channel Separation, V_{O1}/V_{O2} (between amps., CA082, CA083)	$A_{VD} = 100$	X	—	120	—	—	120	—	dB

CA080, CA081, CA082, CA083, CA084 Series

ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$, $T_A = 0$ to 70°C for types supplied in plastic dual-in-line packages (E Suffix). $V^+ = \pm 15\text{ V}$

The limits for the CA080C, CA081C, and CA082C in TO-5 packages are the same as those for the types in this chart.

CHARACTERISTIC	TEST CONDITIONS		LIMITS			UNITS
			CA080E, T CA081E, T CA082E, T CA083E CA084E			
			Min.	Typ.	Max.	
Input Offset Voltage, V_{IO}	$R_S = 50\Omega$	X	—	5	15	mV
		X	—	—	20	
Temperature Coefficient of Input Offset Voltage, αV_{IO}	$R_S = 50\Omega$	X	—	10	—	$\mu\text{V}/^\circ\text{C}$
Input Offset Current, I_{IO}		X	—	5	30	pA
		X	—	—	1	nA
Input Current		X	—	15	50	pA
		X	—	—	2	nA
Common-Mode Input Voltage Range, V_{ICR}		X	± 10	—	—	V
Maximum Output Voltage Swing, V_{OP-P}	$R_L = 10\text{ k}\Omega$	X	24	27	—	V
	$R_L \geq 10\text{ k}\Omega$	X	24	—	—	
	$R_L \geq 2\text{ k}\Omega$	X	20	24	—	
Large-Signal Differential Voltage Gain, A_{VD}	$R_L \geq 2\text{ k}\Omega$, $V_O = \pm 10\text{V}$	X	25	200	—	V/mV
		X	—	—	—	
Unity-Gain Bandwidth		X	—	5	—	MHz
Input Resistance, R_i		X	—	1.5	—	$\text{T}\Omega$
Common-Mode Rejection Ratio, CMRR	$R_S < 10\text{ k}\Omega$	X	70	76	—	dB
Power Supply Rejection Ratio, PSRR ($\Delta V^+ / \pm \Delta V_{IO}$)	$R_S < 10\text{ k}\Omega$	X	70	76	—	dB
Supply Current, I^+ (per amp., CA082, CA083)	No load, No Signal	X	—	1.4	2.8	mA
Channel Separation, V_{O1}/V_{O2} (between amps., CA082, CA083)	$A_{VD} = 100$	X	—	120	—	dB

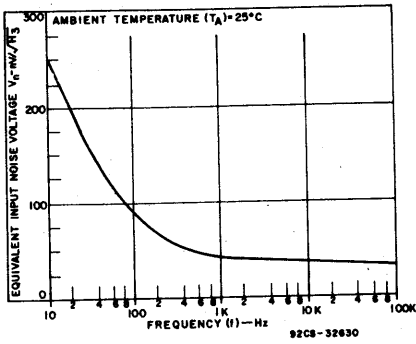


Fig. 3 - Noise voltage as a function of frequency.

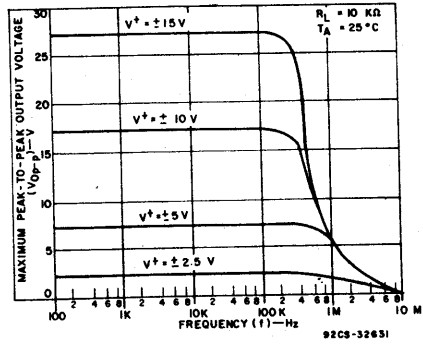


Fig. 4 - Output voltage as a function of frequency.

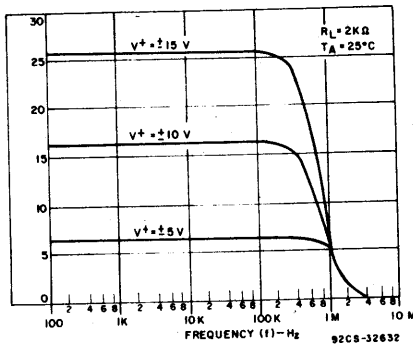


Fig. 5 - Output voltage as a function of frequency.

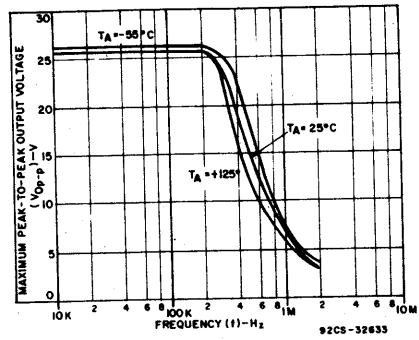


Fig. 6 - Output voltage as a function of frequency.

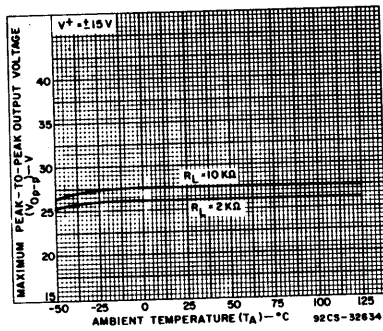


Fig. 7 - Output voltage as a function of ambient temperature.

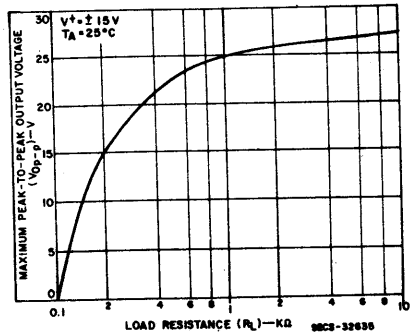


Fig. 8 - Output voltage as a function of load resistance.

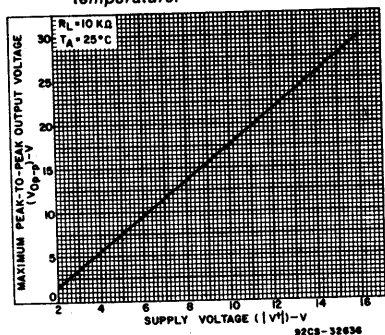


Fig. 9 - Output voltage as a function of supply

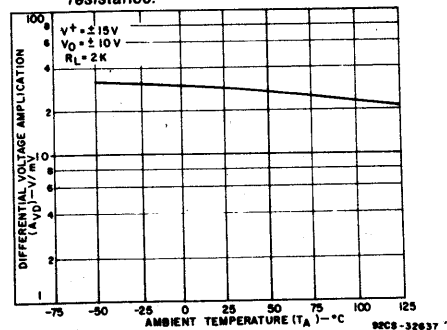


Fig. 10 - Differential voltage amplification as a function of ambient temperature.

CA080, CA081, CA082, CA083, CA084 Series

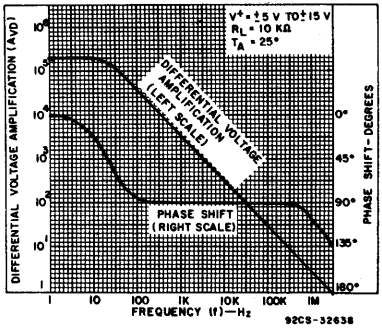


Fig. 11 - Differential voltage amplification as a function of frequency.

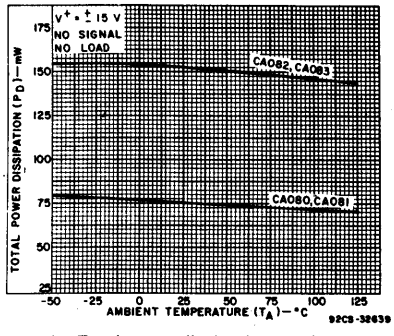


Fig. 12 - Total power dissipation as a function of ambient temperature.

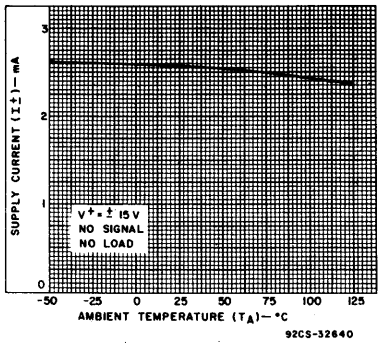


Fig. 13 - Supply current as a function of ambient temperature.

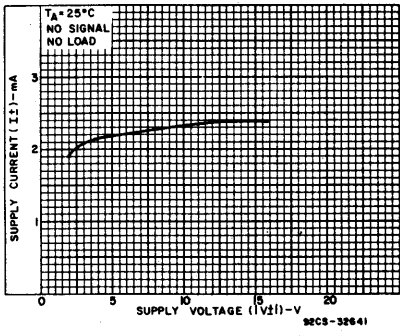


Fig. 14 - Supply current as a function of supply voltage.

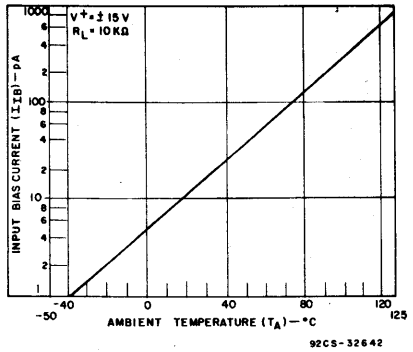


Fig. 15 - Input bias current as a function of ambient temperature.

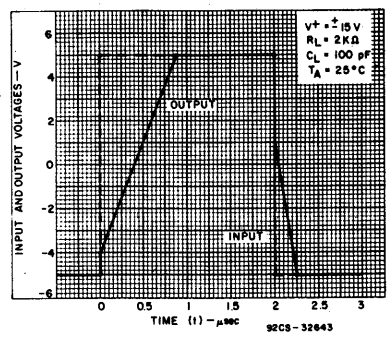


Fig. 16 - Voltage follower large-signal pulse response.

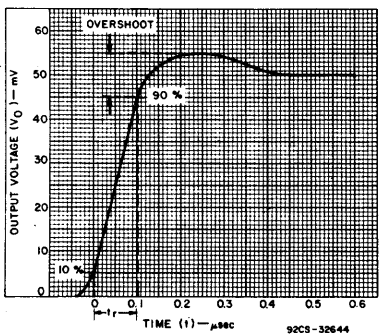


Fig. 17 - Output voltage as a function of elapsed time.

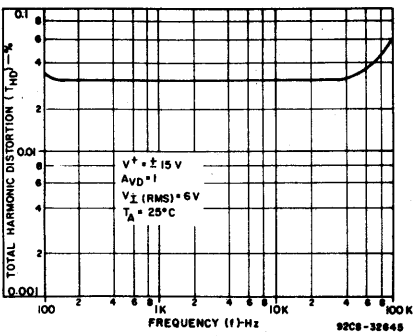


Fig. 18 - Total harmonic distortion as a function of frequency.

CA080, CA081, CA082, CA083, CA084 Series

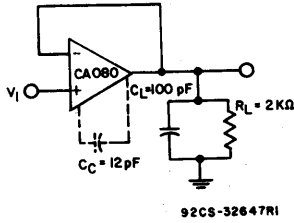


Fig. 19 - Unity-gain amplifier.

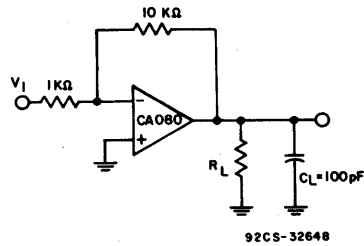


Fig. 20 - 10X inverting amplifier.

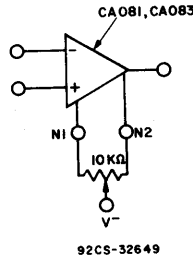
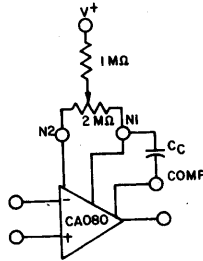


Fig. 21 - Input-offset voltage null circuits.

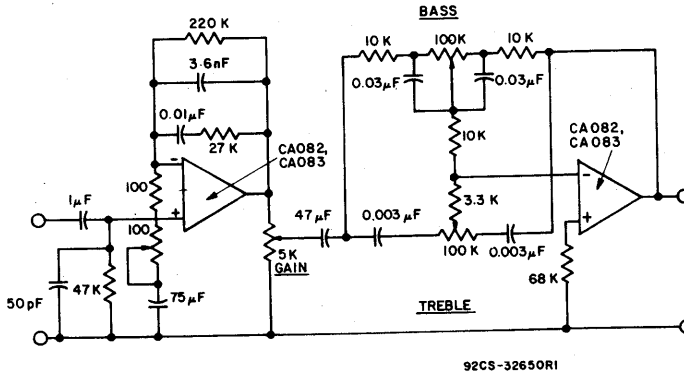


Fig. 22 - IC preamplifier.

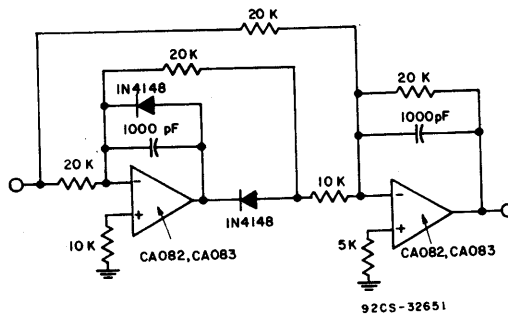


Fig. 23 - Unity-gain absolute-value amplifier.